



# **SPECIFICATION**

• Supplier : Samsung electro-mechanics • Samsung P/N : CL31B105KCHNNNE

Product : Multi-layer Ceramic Capacitor
Description : CAP, 1μF, 100V, ±10%, X7R, 1206

### A. Samsung Part Number

## <u>CL 31 B 105 K C H N N N E</u>

Series	Samsung Multi-layer Ceramic Capacitor		
Size	1206 (inch code)	L: 3.2 ± 0.2 mm V	V: 1.6 ± 0.2 mm
Dielectric	X7R Inner electrode Ni		Ni
Capacitance	1 <i>μ</i> F	Termination	Cu
Capacitance	±10 %	Plating	Sn 100% (Pb Free)
tolerance	<b>Product</b> Normal		Normal
Rated Voltage	100 V	Special	Reserved for future use
Thickness	1.6 ± 0.2 mm	Packaging Embossed Type, 7" reel	

#### **B. Samsung Reliablility Test and Judgement condition**

	Performance	Test condition	
Capacitance	Within specified tolerance	1khz±10% 1.0±0.2Vrms	
Tan (DF)	0.025 max.		
Insulation	10,000Mohm or 500Mohm⋅ <i>μ</i> F	Rated Voltage 60~120 sec.	
Resistance	Whichever is Smaller		
Appearance	No abnormal exterior appearance	Microscope (×10)	
Withstanding	No dielectric breakdown or	200% of the rated voltage	
Voltage	mechanical breakdown		
Temperature	X7R		
Characterisitcs	(From -55 to 125 , Capacitance change shoud be within ±15%)		
Adhesive Strength	No peeling shall be occur on the	500g·F, for 10±1 sec.	
of Termination	terminal electrode		
Bending Strength	Capacitance change : within ±12.5%	Bending to the limit (1mm)	
		with 1.0mm/sec.	
Solderability	More than 75% of terminal surface	1) Sn63Pb37 solder	
	is to be soldered newly	235±5 , 5±0.5sec.	
		2) SnAg3.0Cu0.5 solder	
		245±5 , 3±0.3sec.	
		(preheating : 80~120 for 10~30sec.)	
Resistance to	Capacitance change : within ±7.5%	Solder pot: 270±5 , 10±1sec.	
Soldering heat	Tan , IR : initial spec.		

	Performance	Test condition
Vibration Test	Capacitance change : within ±5%	Amplitude : 1.5mm
	Tan δ, IR : initial spec.	From 10Hz to 55Hz (return : 1min.)
		2hours × 3 direction (x, y, z)
Moisture	Capacitance change : within ±12.5%	With rated voltage
Resistance	Tan δ : 0.05 max	40±2 , 90~95%RH, 500+12/-0hrs
	IR: 500Mohm or 25Mohm · μF	
	Whichever is Smaller	
High Temperature	Capacitance change : within ±12.5%	With 200% of the rated voltage
Resistance	Tan δ : 0.05 max	Max. operating temperature
	IR : 1000Mohm or 50Mohm · μF	
	Whichever is Smaller	1000+48/-0hrs
Temperature	Capacitance change : within ±7.5%	1 cycle condition
Cycling	Tan δ, IR : initial spec.	Min. operating temperature 25
		Max. operating temperature 25
		5 cycle test

## C. Recommended Soldering method :

Reflow ( Reflow Peak Temperature : 260+0/-5 , 10sec. Max )

<sup>\*</sup> For the more detail Specification, Please refer to the Samsung MLCC catalogue.